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United States Patent [19]

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Emori

[45] Date of Patent: **** Mar. 9, 1993**

[54] COATING THICKNESS TESTER

4,567,436 1/1986 Koch 324/230
4,715,007 12/1987 Fujita et al. 364/563

[75] Inventor: **Motohiko Emori, Tokyo, Japan**

FOREIGN PATENT DOCUMENTS

[73] Assignee: **Kett Electric Laboratory, Tokyo, Japan**

1038414 8/1966 United Kingdom 33/761

[**] Term: **14 Years**

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[21] Appl. No.: **534,417**

[22] Filed: **Jun. 7, 1990**

[57] CLAIM

[30] Foreign Application Priority Data

The ornamental design for a coating thickness tester, as shown.

Feb. 28, 1990 [JP] Japan 2-6153

[52] U.S. Cl. **D10/70; D10/72**

[58] Field of Search **D10/70, 72; 33/755-765; 324/229, 230; 364/563**

DESCRIPTION

[56] References Cited

U.S. PATENT DOCUMENTS

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FIG. 1 is a front elevational view of coating thickness tester showing my new design;
FIG. 2 is a rear elevational view;
FIG. 3 is a top plan view;
FIG. 4 is a bottom plan view;
FIG. 5 is a left side elevational view;
FIG. 6 is a right side elevational view; and,
FIG. 7 is a front, top and right side perspective view thereof.

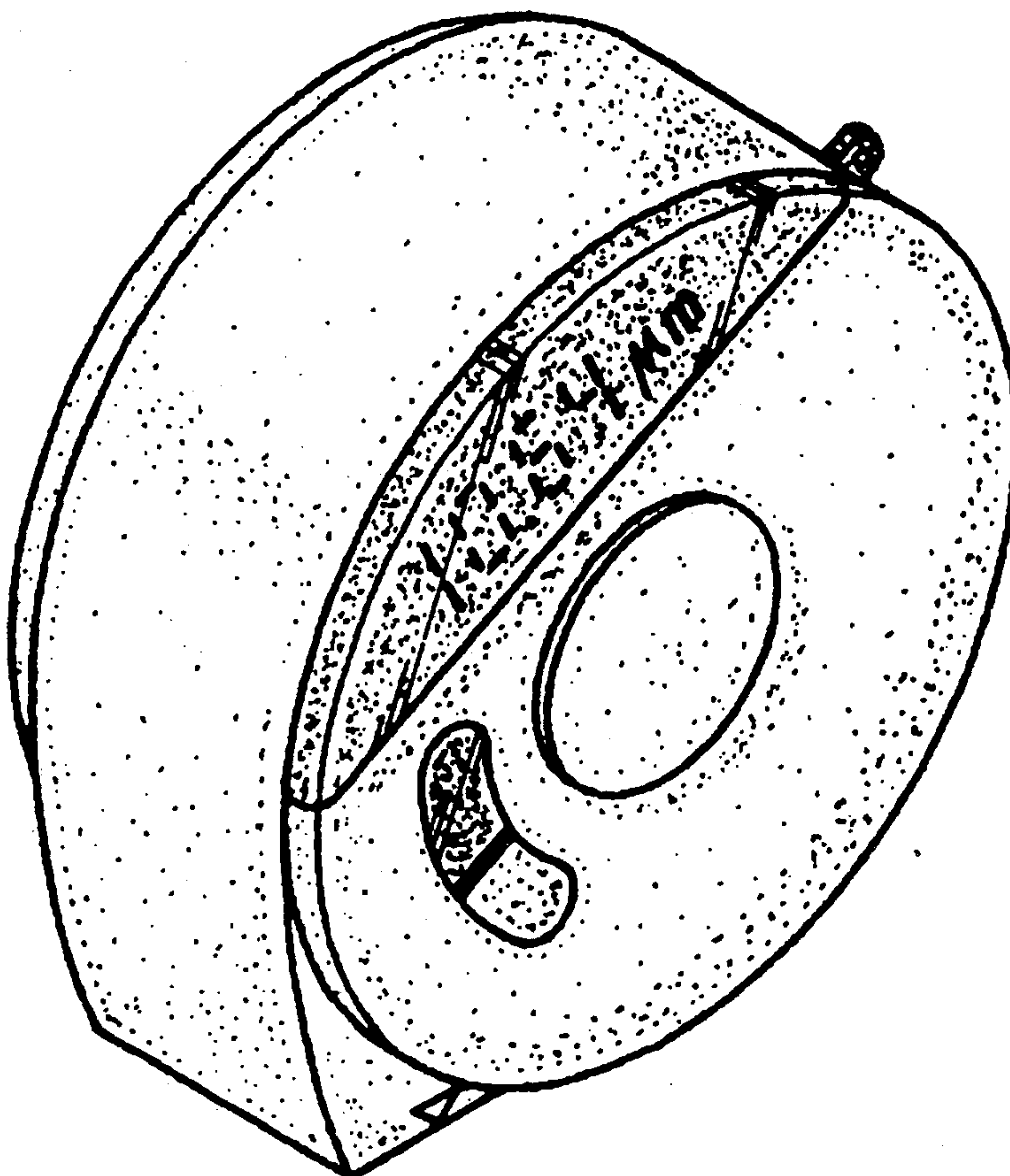


FIG. 1



FIG. 2

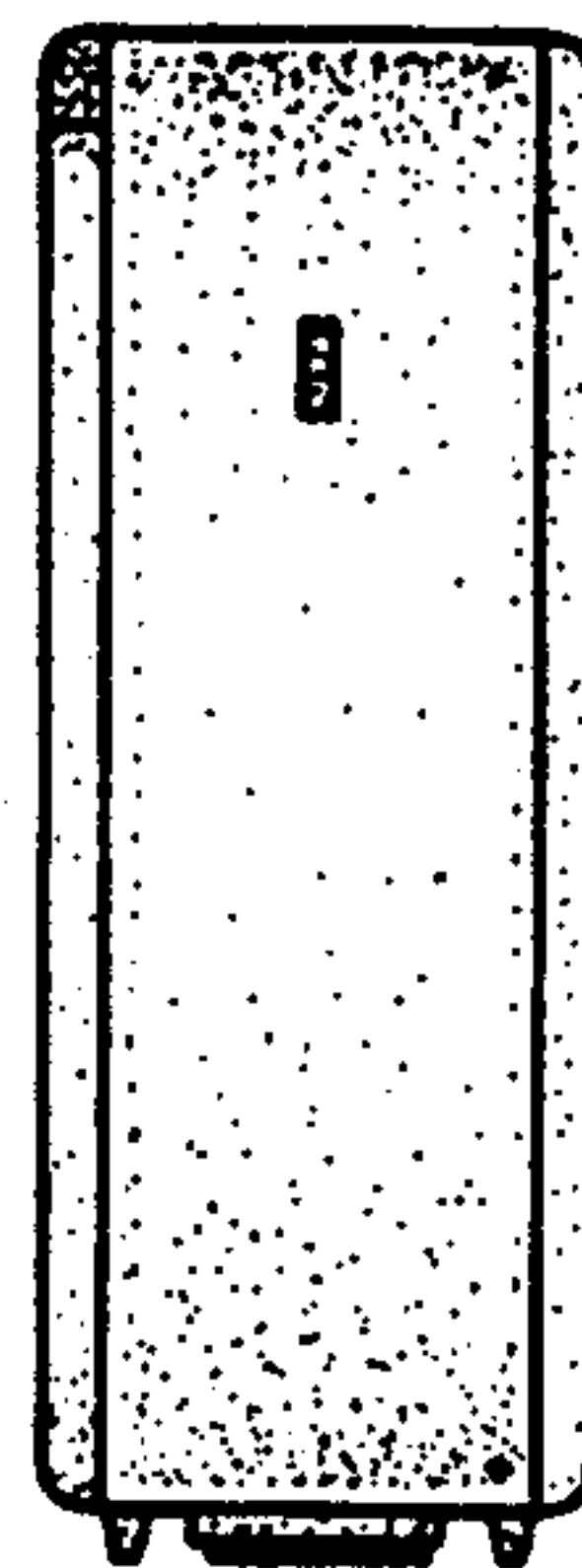


FIG. 3

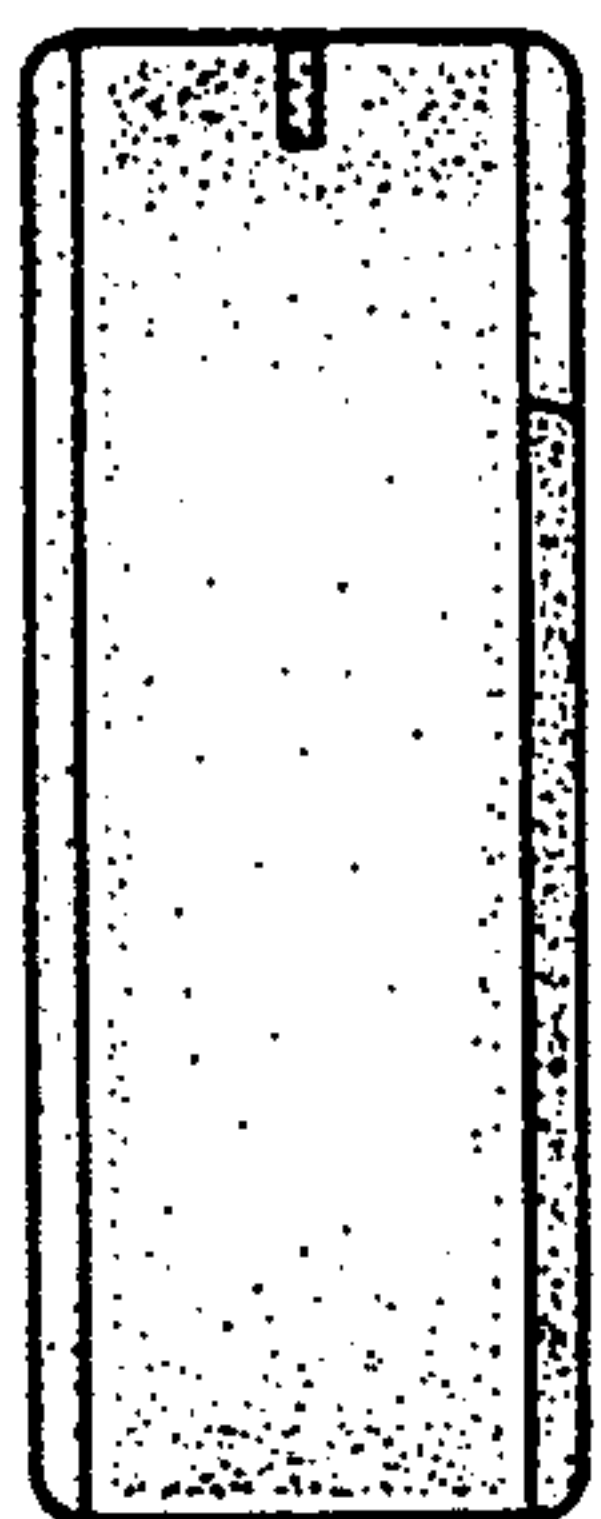


FIG. 4



FIG. 5

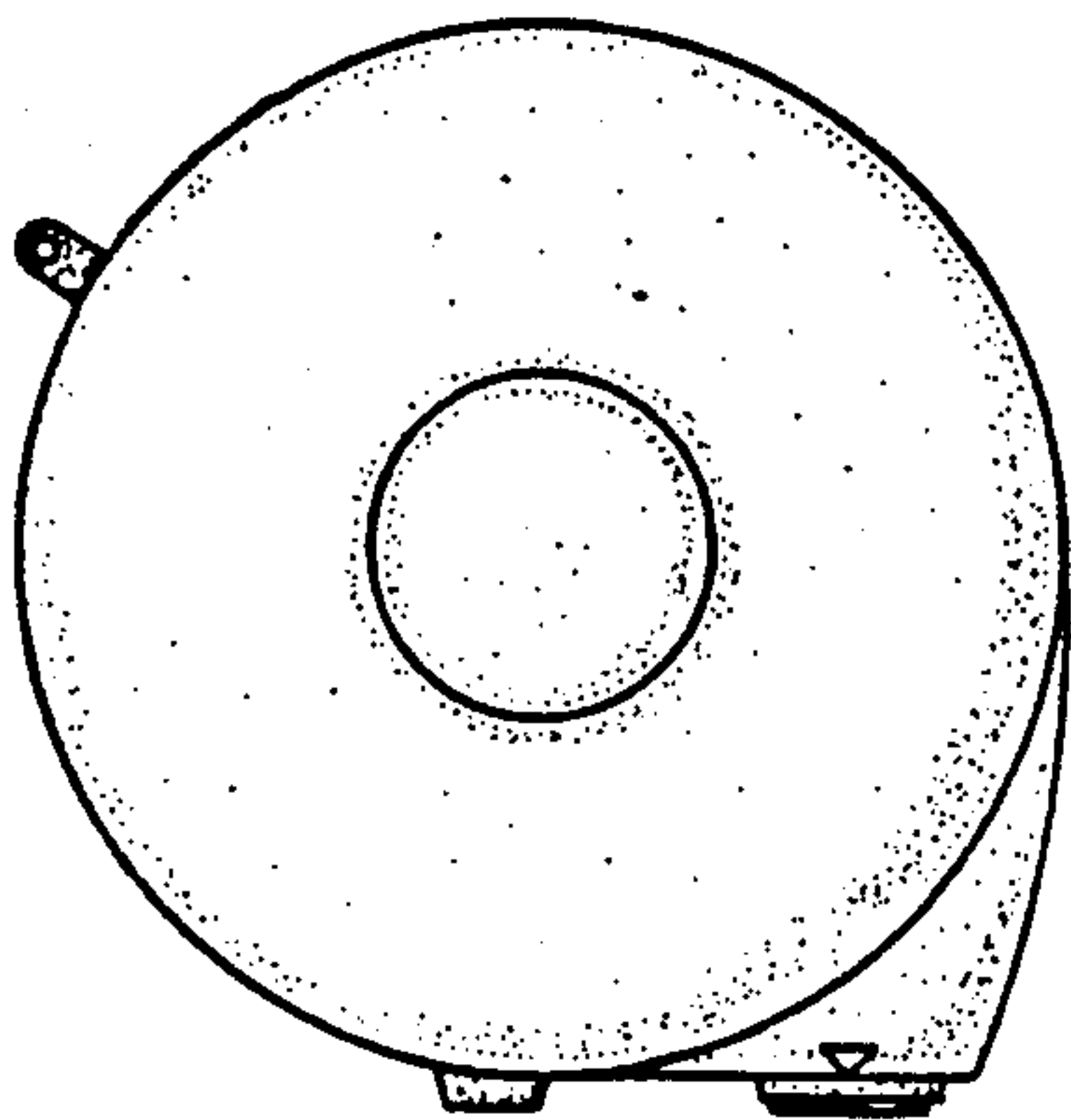


FIG. 6

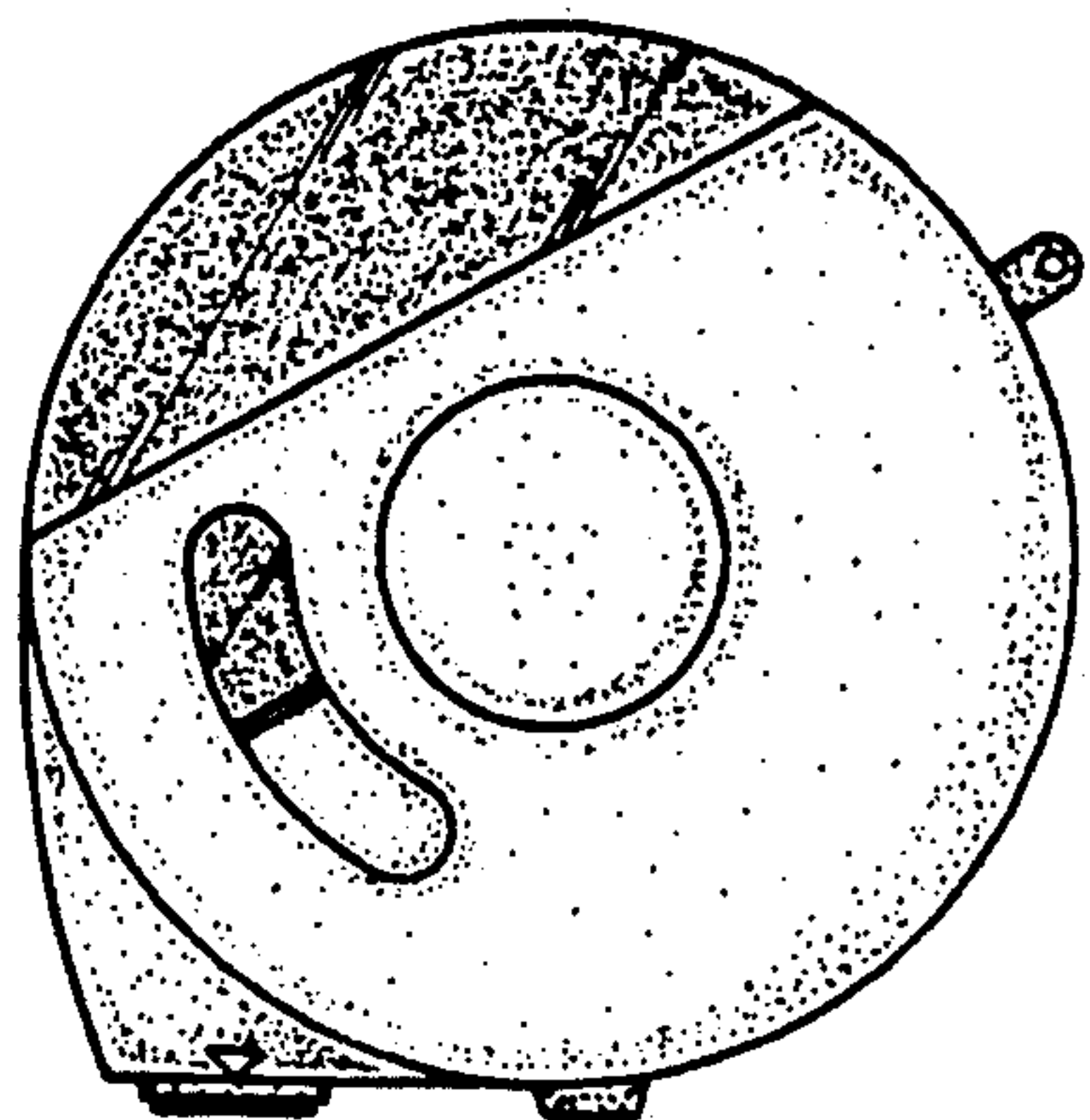


FIG. 7

